

INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)	ATTY. DOCKET No. 6-1032-021	SERIAL NO. 09/160,133
	APPLICANT : LELEU ET AL	
	FILING DATE : Sept 25, 1998	GROUP <i>Art Unit 1623</i>

U.S. PATENT DOCUMENTS

Examiner Initial	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>EW</i>	4.408.041	Oct. 4, 1983	Hirao et al.			
<i>EW</i>	4.248.895	Feb. 3, 1981	Stroz et al.	426	658	
<i>EW</i>	3.918.986	Nov. 11, 1975	Hiraiwa	127	29	
<i>EW</i>	3.915.736	Oct. 28, 1975	Oyamada et al.	426	213	
<i>EW</i>	4.511.654	Apr. 16, 1985	Rohrbach et al.	435	95	
<i>EW</i>	4.429.122	Jan. 31, 1984	Zupancic	536	124	
<i>EW</i>	4.849.023	Jul. 18, 1989	Devos et al	568	872	
<i>EW</i>	4.846.430	Jul. 11, 1988	Devos et al	127	40	
<i>EW</i>	4.831.129	May 16, 1989	Serpelloni	536	4.1	

Already of record

FOREIGN PATENT DOCUMENTS

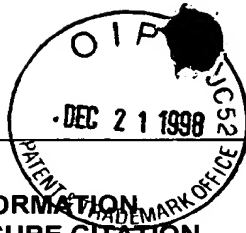
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
							Yes	No
<i>EW</i>	1	0 735 042	10.02.1986	EUROPE	—	—		✓
<i>EW</i>	2	JP 49.87619 + abs	08.22.1974	JAPAN	—	—	✓	
<i>EW</i>	3	JP 50.59312 + abs	22.05.1975	JAPAN	—	—	✓	
<i>EW</i>	4	JP 51.113813 + ab	10.07.1976	JAPAN	—	—	✓	
<i>EW</i>	5	JP 49.110620	10.22.1974	JAPAN	—	—	✓	

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>EW</i>	S. OHNO, ET AL : "X-Ray crystal structure of maltitol-CARBOHYDRATE RESEARCH (01.01.1982), Vol. 108, AMSTERDAM pages 163-171

EXAMINER <i>E. White</i>	DATE CONSIDERED <i>8/24/1999</i>
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* EXAMINER : Initial if reference considered, whether or not citation is in conformance with MPEP 609 ; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
							Yes	No
<i>EW</i> ✓	6	57.47680 + abs	04.05.1975	JAPAN	—	—	✓	
<i>EW</i> ✓	7	58.58145 + abs	09.20.1983	JAPAN	—	—	✓	
	8	50.59342 + abs	22.05.1975	JAPAN	<i>duplicate</i>			
<i>EW</i>	9	1.383.724	02.12.1975	GB	—	—		
<i>EW</i>	10	WO 95/10627	04.20.1995	PCT	—	—		
<i>EW</i> ✓	11	50.129769	10.14.1975	JAPAN	—	—	✓	
<i>EW</i> ✓	12	48.61665	08.29.1973	JAPAN	—	—	✓	

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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